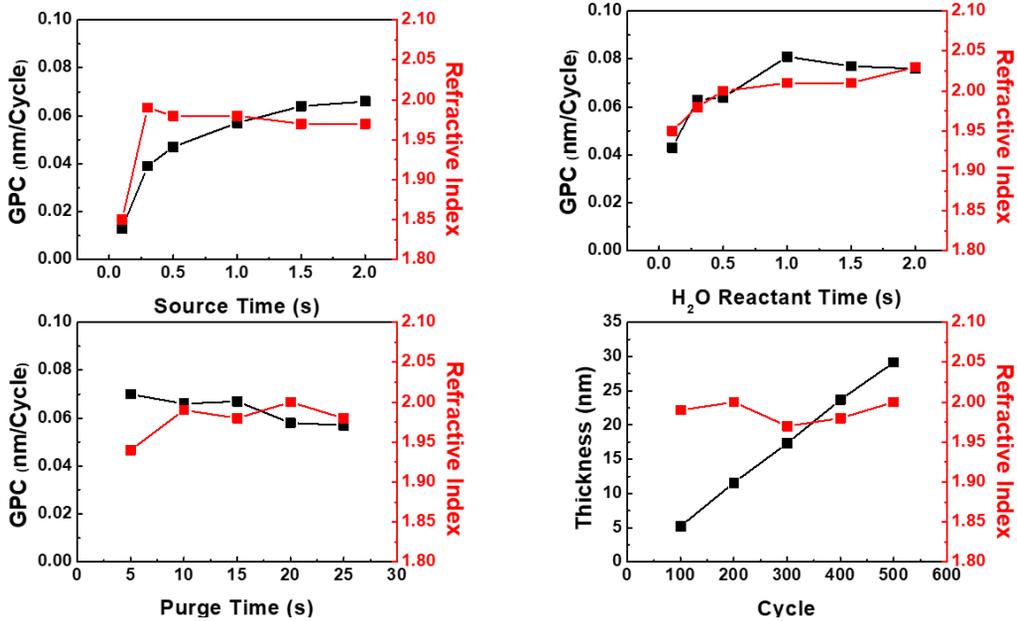
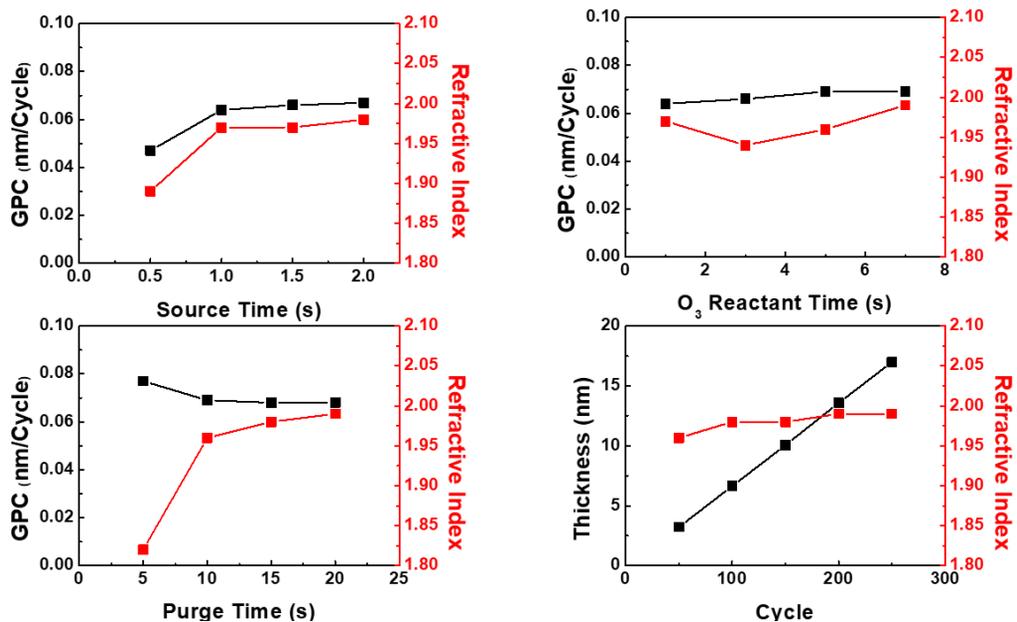


Deposition and Electrical Characterization of Hafnia ALD Thin Films Using Cp-Based Precursors

Hyun Woo Jeong



Saturation and Growth Characteristics of Thermal ALD HfO₂ using H₂O Oxidant



Saturation and Growth Characteristics of Thermal ALD HfO₂ using O₃ Oxidant